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Amendments to the Claims:

This listing of claims will replace all prior versions, and listings, of claims in the application:

Listing of Claims:

 (Original) Position-sensitive detector for measuring charged particles comprising a surface region, which is formed by an amorphous layer with a structured, metallic layer disposed above it,

characterised in that

the structure of the metallic layer is continued into the amorphous layer.

- 2. (Original) Position-sensitive detector according to claim 1, characterised in that the structure of the metallic layer extends through the amorphous layer into the crystalline structure, onto which the amorphous layer is applied.
- (Currently Amended) Position-sensitive detector according to claim 1 or 2,
 characterised in that the amorphous layer is formed from germanium or silicon.
- (Currently Amended) Position-sensitive detector according to any one of the
 preceding claims claim 1, characterised in that the metallic layer consists of
 aluminium, palladium or gold.
- 5. (Currently Amended) Position-sensitive detector according to any one of the preceding claims claim 1, characterised in that the crystalline region beneath the amorphous layer is formed of germanium, silicon or a III-V compound.
- 6. (Currently Amended) Position-sensitive detector according to any one of the preceding claims claim 1, characterized in that the structure is formed from segments, which provide a mutual spacing of less than 200 μm, in particular, a spacing of less than 100 μm, by particular preference less than 20 μm.

- 7. (Currently Amended) Position-sensitive detector according to any one of the preceding claims claim 1, characterised in that the amorphous layer is applied to a semiconductor material.
- 8. (Currently Amended) Position-sensitive detector according to any one of the preceding claims claim 1, characterised in that the amorphous layer provides an electrical conductivity, which is substantially less than the conductivity of the material disposed beneath the amorphous layer.
- 9. (Currently Amended) Tomograph or Compton camera with a detector according to any one of the preceding claims claim 1.